



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AONY36304**

**30V Dual Asymmetric N-Channel MOSFET**

### General Description

- Trench Power MOSFET technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

### Product Summary

|                                  | <u>Q1</u> | <u>Q2</u> |
|----------------------------------|-----------|-----------|
| $V_{DS}$                         | 30V       | 30V       |
| $I_D$ (at $V_{GS}=10V$ )         | 51A       | 85A       |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | <5.2mΩ    | <2.8mΩ    |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | <8.6mΩ    | <3.5mΩ    |

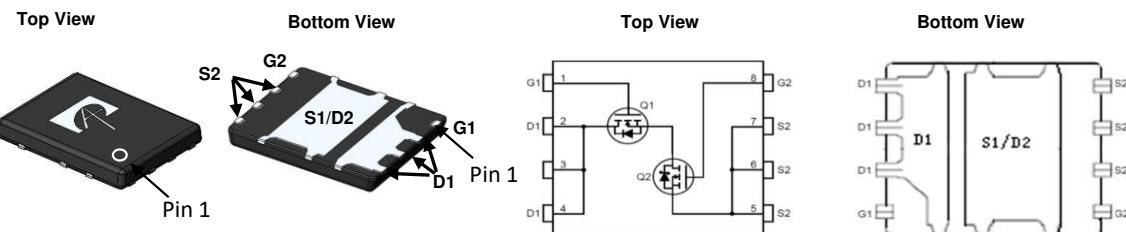
### Applications

- DC/DC Converters in Computing
- POL in Telecom and Industrial

100% UIS Tested  
100%  $R_g$  Tested



### DFN 5x6D



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AONY36304             | DFN 5x6D     | Tape & Reel | 3000                   |

### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                              | Symbol         | Max Q1     | Max Q2   | Units |
|--|----------------|------------|----------|-------|
| Drain-Source Voltage                   | $V_{DS}$       | 30         | 30       | V     |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 20$   | $\pm 12$ | V     |
| Continuous Drain Current               | $I_D$          | 51         | 83       | A     |
| $T_C=100^\circ C$                      |                | 32         | 52       |       |
| Pulsed Drain Current <sup>c</sup>      | $I_{DM}$       | 110        | 180      | A     |
| Continuous Drain Current               | $I_{DSM}$      | 20         | 26       | A     |
| $T_A=70^\circ C$                       |                | 16         | 21       |       |
| Avalanche Current <sup>c</sup>         | $I_{AS}$       | 50         | 75       | A     |
| Avalanche energy L=0.01mH <sup>c</sup> | $E_{AS}$       | 12.5       | 28       | mJ    |
| Power Dissipation <sup>B</sup>         | $P_D$          | 21         | 31.5     | W     |
| $T_C=100^\circ C$                      |                | 8.5        | 12.5     |       |
| Power Dissipation <sup>A</sup>         | $P_{DSM}$      | 3.1        | 3.1      | W     |
| $T_A=70^\circ C$                       |                | 2          | 2        |       |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150 |          | °C    |

### Thermal Characteristics

| Parameter   | Symbol          | Typ Q1 | Typ Q2 | Max Q1 | Max Q2 | Units |
|---|-----------------|--------|--------|--------|--------|-------|
| Maximum Junction-to-Ambient <sup>A</sup>                | $R_{\theta JA}$ | 30     | 30     | 40     | 40     | °C/W  |
| Maximum Junction-to-Ambient <sup>A,D</sup> Steady-State |                 | 50     | 50     | 65     | 65     | °C/W  |
| Maximum Junction-to-Case                                | $R_{\theta JC}$ | 4.6    | 3.1    | 6      | 4      | °C/W  |

**Q1 Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ  | Max      | Units            |
|-----------------------------|---------------------------------------|--|-----|------|----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |      |          |                  |
| $\text{BV}_{\text{DSS}}$    | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$   | 30  |      |          | V                |
| $I_{\text{DSS}}$            | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                |     | 1    | 5        | $\mu\text{A}$    |
| $I_{\text{GSS}}$            | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$                                       |     |      | $\pm100$ | nA               |
| $V_{\text{GS(th)}}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$  | 1.3 | 1.75 | 2.2      | V                |
| $R_{\text{DS(ON)}}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=20\text{A}$<br>$T_J=125^\circ\text{C}$                 |     | 3.8  | 5.2      | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=20\text{A}$   |     | 5.4  | 7.6      |                  |
| $g_{\text{FS}}$             | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=20\text{A}$   |     | 80   |          | S                |
| $V_{\text{SD}}$             | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$  |     | 0.7  | 1        | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |      | 30       | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |      |          |                  |
| $C_{\text{iss}}$            | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$                           |     | 1000 |          | pF               |
| $C_{\text{oss}}$            | Output Capacitance                    |  |     | 290  |          | pF               |
| $C_{\text{rss}}$            | Reverse Transfer Capacitance          |  |     | 50   |          | pF               |
| $R_g$                       | Gate resistance                       | $f=1\text{MHz}$  | 0.2 | 0.6  | 1        | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |      |          |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$                         |     | 17   | 30       | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |  |     | 8    | 15       | nC               |
| $Q_{\text{gs}}$             | Gate Source Charge                    |  |     | 2.8  |          | nC               |
| $Q_{\text{gd}}$             | Gate Drain Charge                     |  |     | 4.1  |          | nC               |
| $t_{\text{D(on)}}$          | Turn-On Delay Time                    | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega, R_{\text{GEN}}=3\Omega$ |     | 7    |          | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |     | 3    |          | ns               |
| $t_{\text{D(off)}}$         | Turn-Off Delay Time                   |  |     | 19   |          | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 2.5  |          | ns               |
| $t_{\text{rr}}$             | Body Diode Reverse Recovery Time      | $I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$                                |     | 11   |          | ns               |
| $Q_{\text{rr}}$             | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$                                |     | 19   |          | nC               |

A. The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{JJA}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .

D. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JJC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

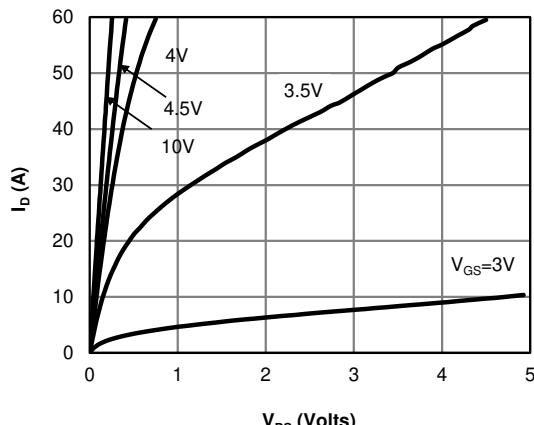
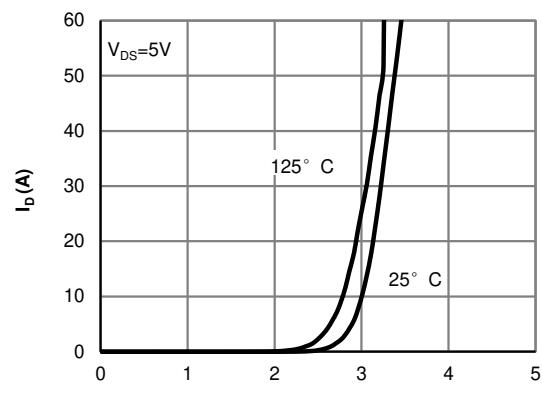
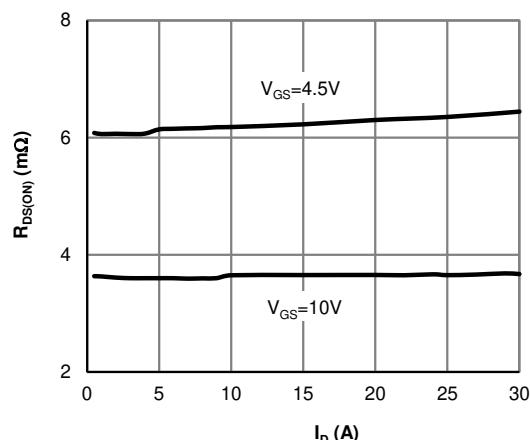
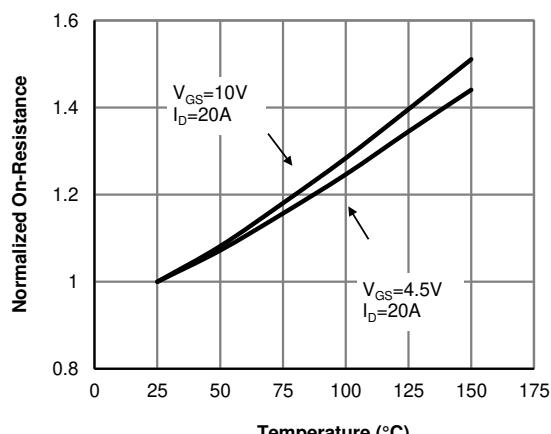
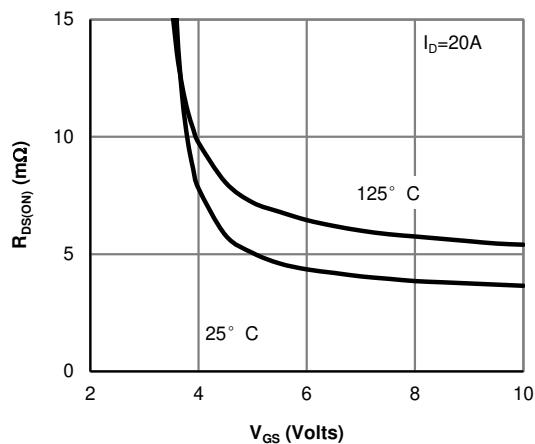
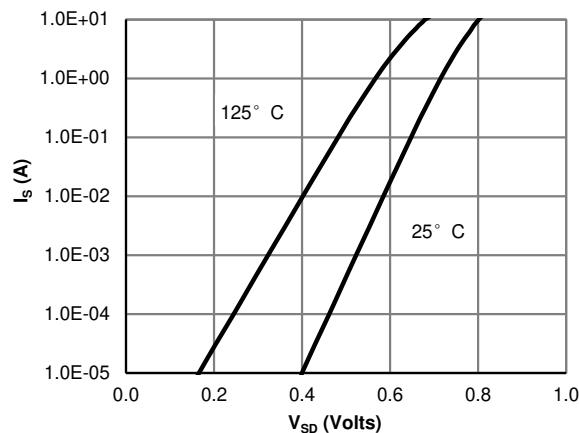
G. The maximum current rating is package limited.

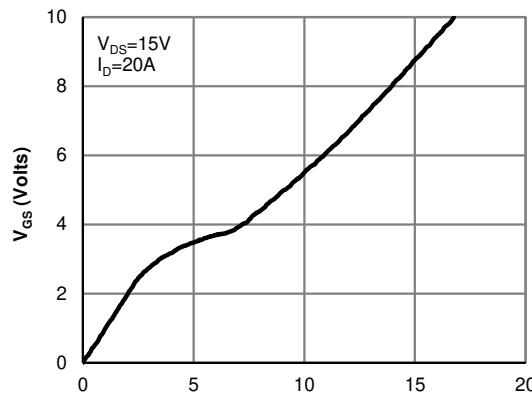
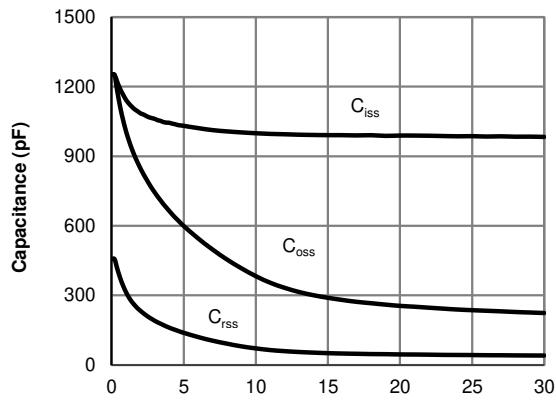
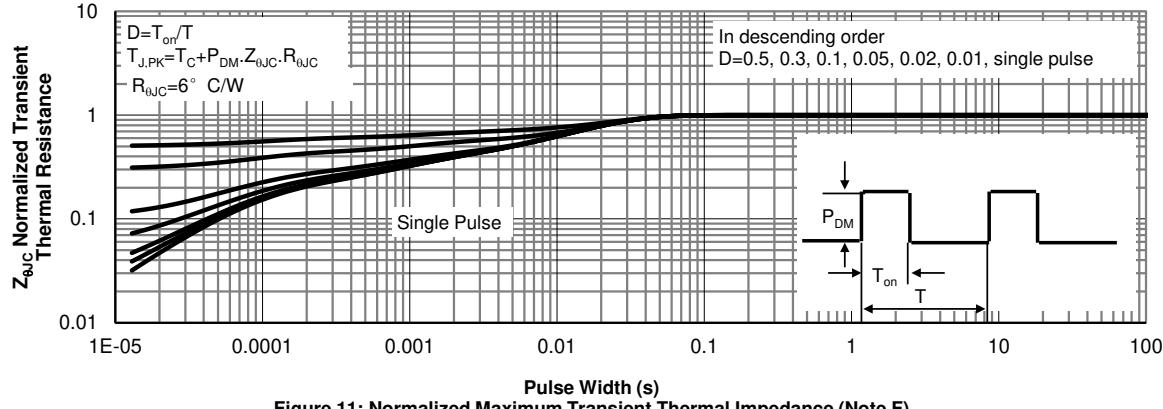
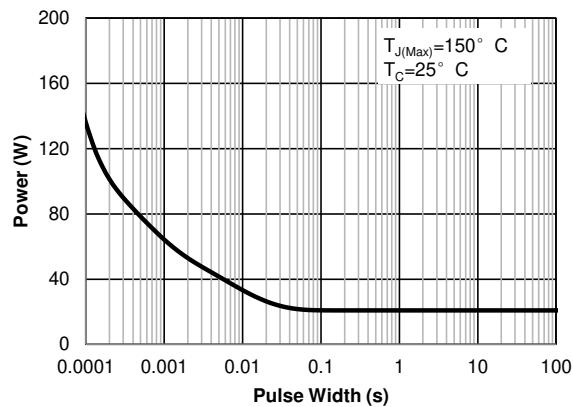
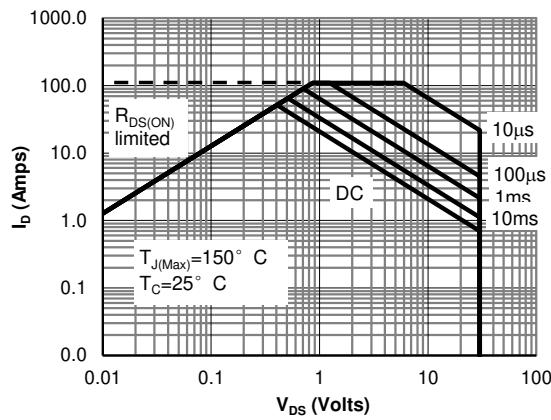
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

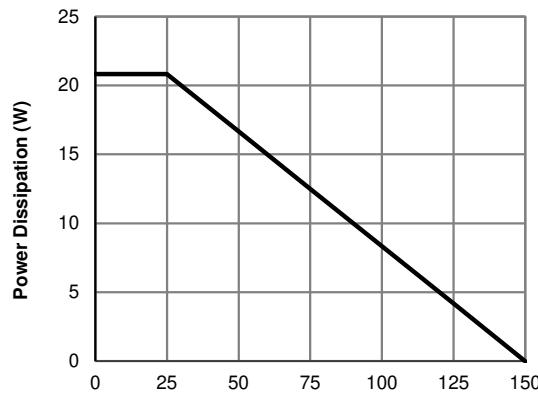
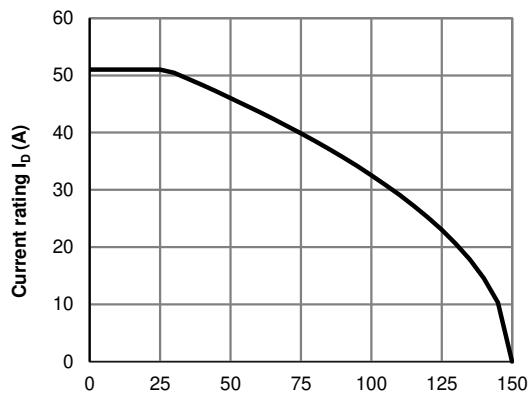
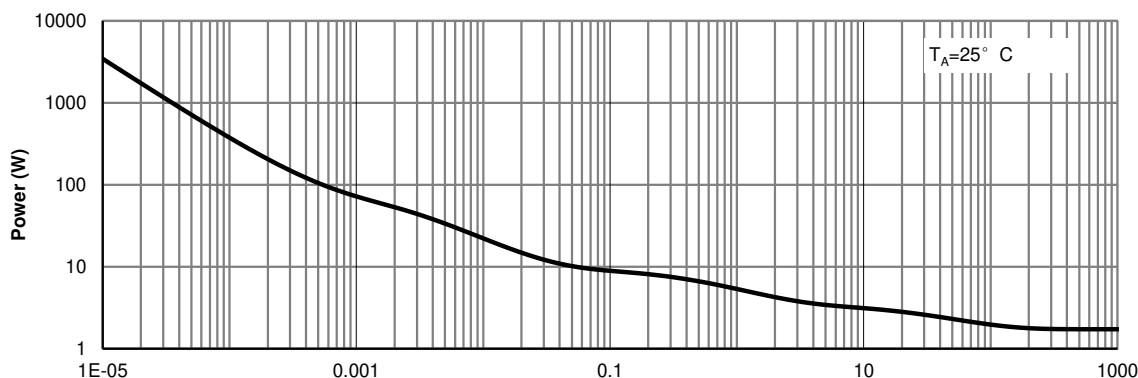
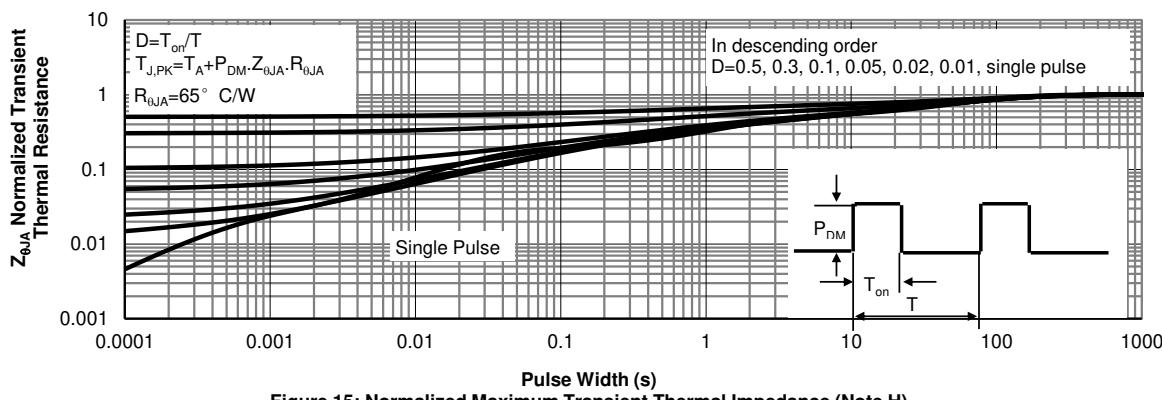
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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**


**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

**Q2 Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ  | Max       | Units            |
|-----------------------------|---------------------------------------|--|-----|------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |      |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$   | 30  |      |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                |     | 1    | 5         | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$                                      |     |      | $\pm 100$ | nA               |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$  | 1.1 | 1.5  | 1.9       | V                |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=20\text{A}$<br>$T_J=125^\circ\text{C}$                 |     | 2.1  | 2.8       | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=20\text{A}$   |     | 3.0  | 4.0       |                  |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=20\text{A}$   |     | 165  |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$  |     | 0.7  | 1         | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |      | 40        | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |      |           |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$                           |     | 1890 |           | pF               |
| $C_{oss}$                   | Output Capacitance                    |  |     | 395  |           | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |  |     | 55   |           | pF               |
| $R_g$                       | Gate resistance                       | $f=1\text{MHz}$  | 1.2 | 2.3  | 3.6       | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |      |           |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$                         |     | 27.5 | 40        | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |  |     | 11.5 | 18        | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 6    |           | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 2.5  |           | nC               |
| $t_{D(\text{on})}$          | Turn-On Delay Time                    | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega, R_{\text{GEN}}=3\Omega$ |     | 7.5  |           | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |     | 3.5  |           | ns               |
| $t_{D(\text{off})}$         | Turn-Off Delay Time                   |  |     | 30   |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 4    |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$                                |     | 12   |           | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$                                |     | 21   |           | nC               |

A. The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DM}}$  is based on  $R_{\text{JJA}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .

D. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

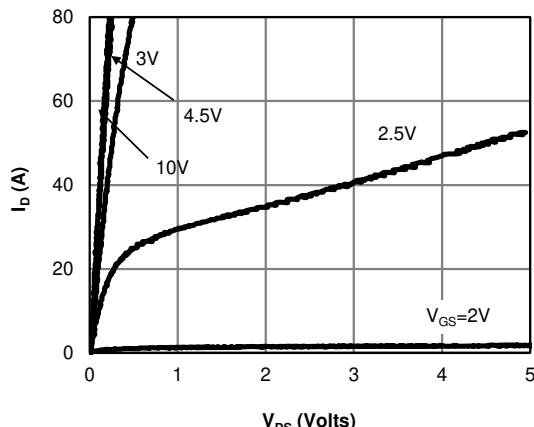
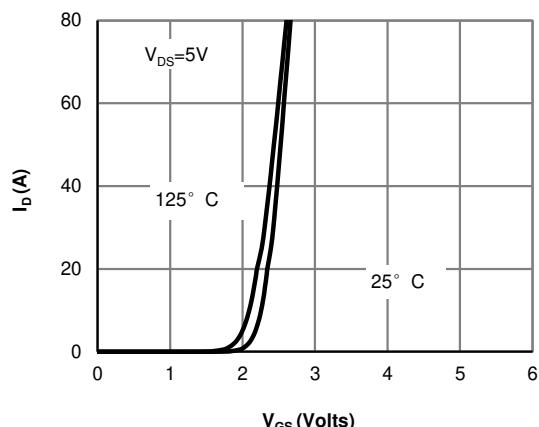
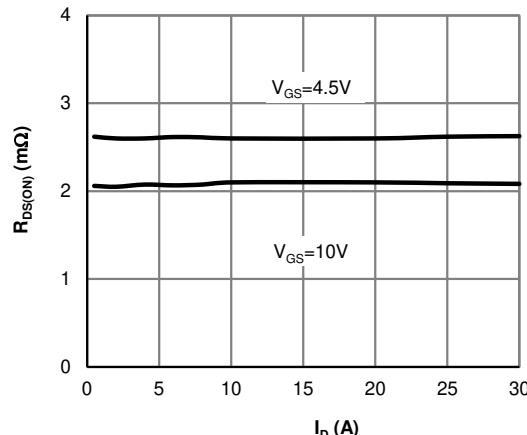
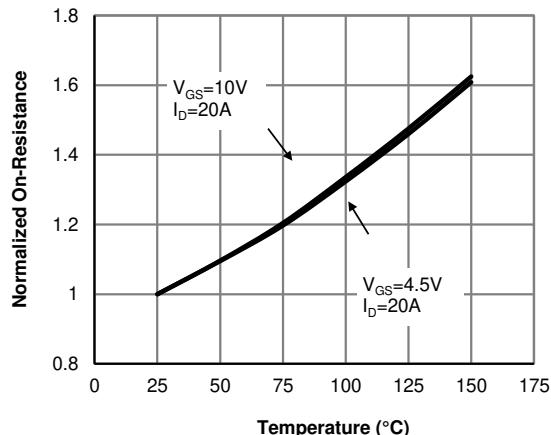
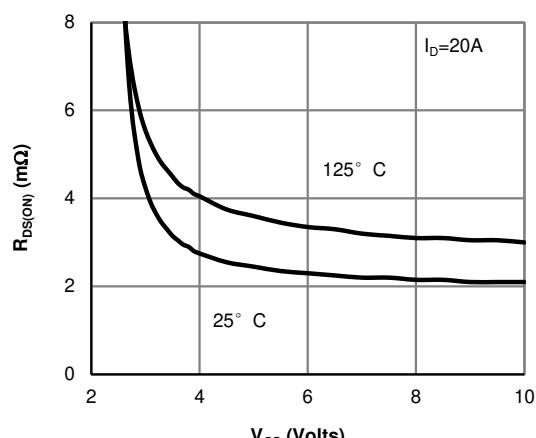
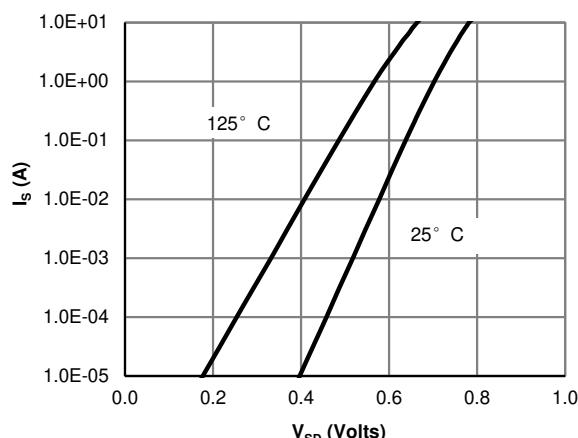
G. The maximum current rating is package limited.

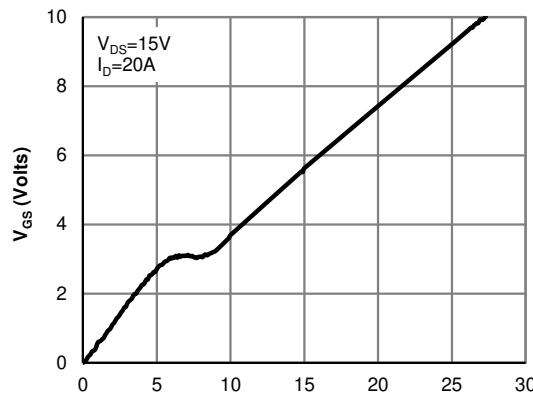
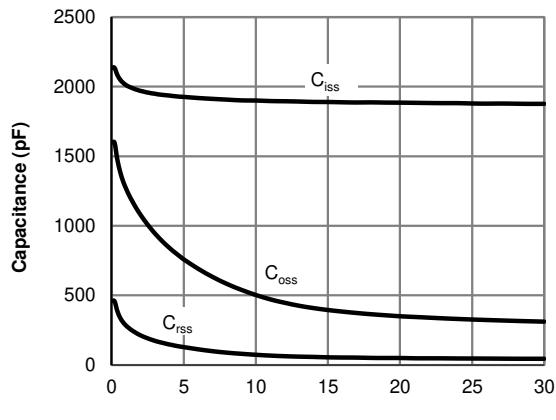
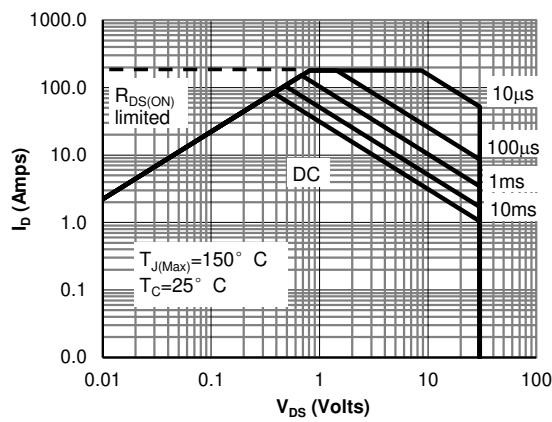
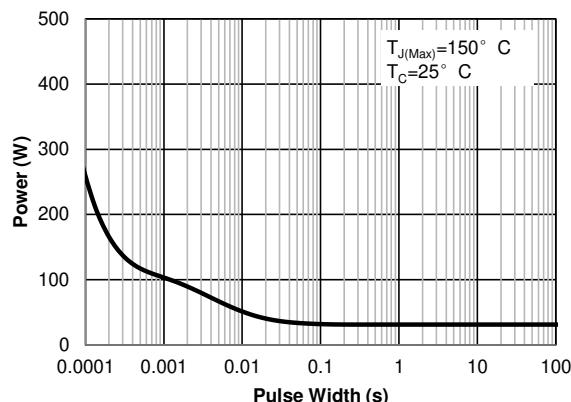
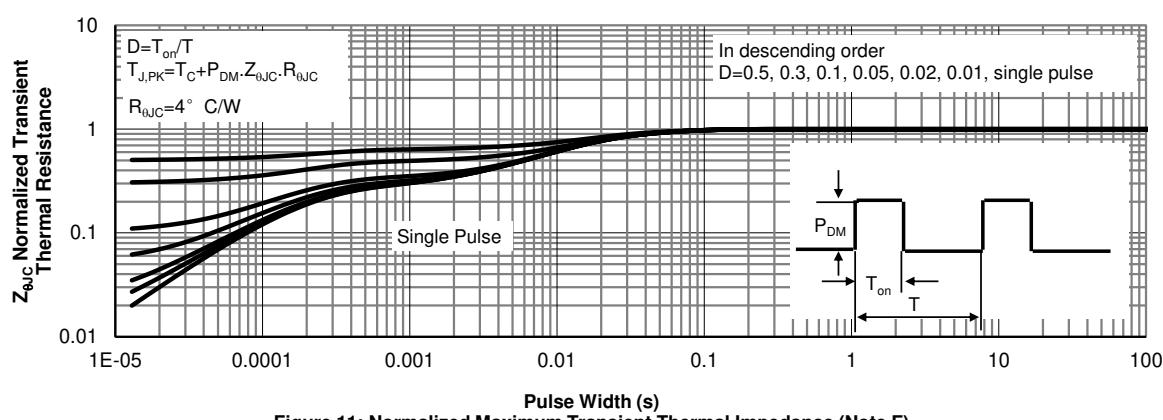
H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

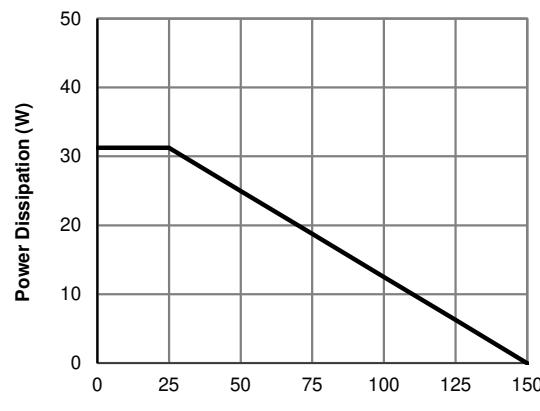
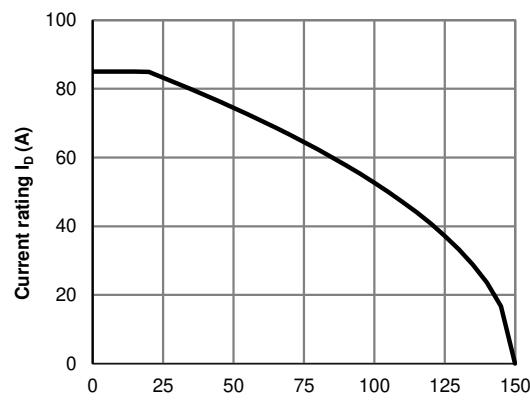
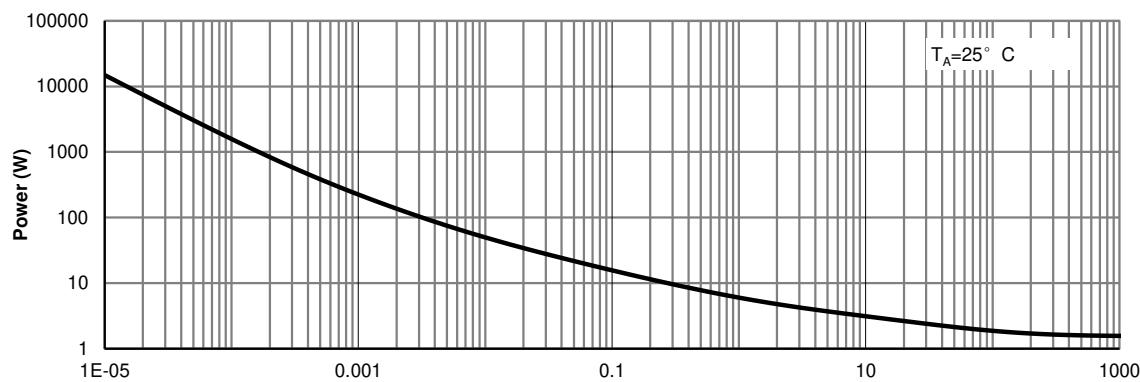
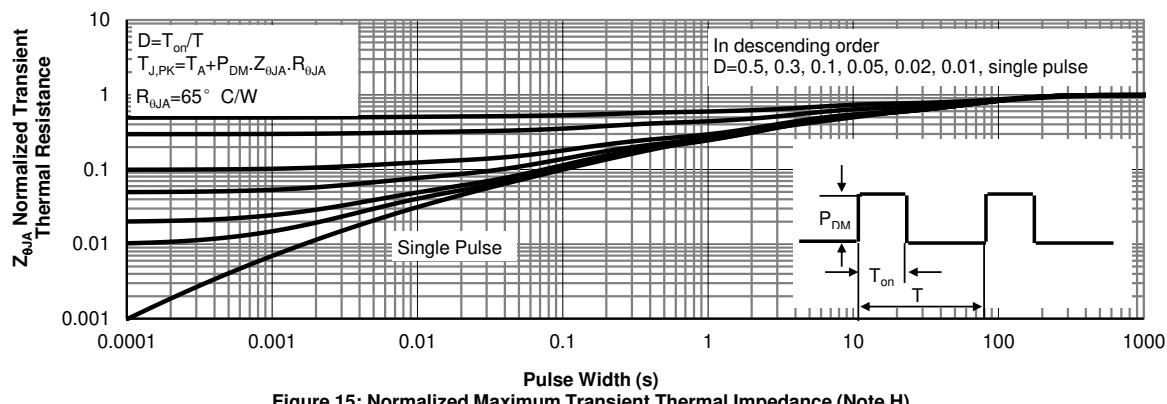
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

Figure A: Gate Charge Test Circuit & Waveforms

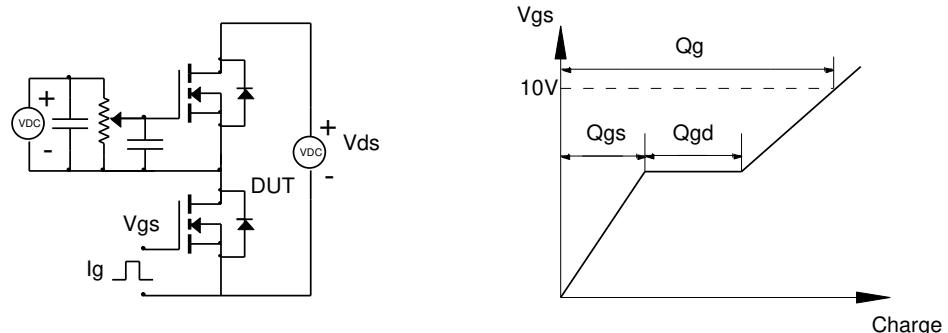


Figure B: Resistive Switching Test Circuit & Waveforms

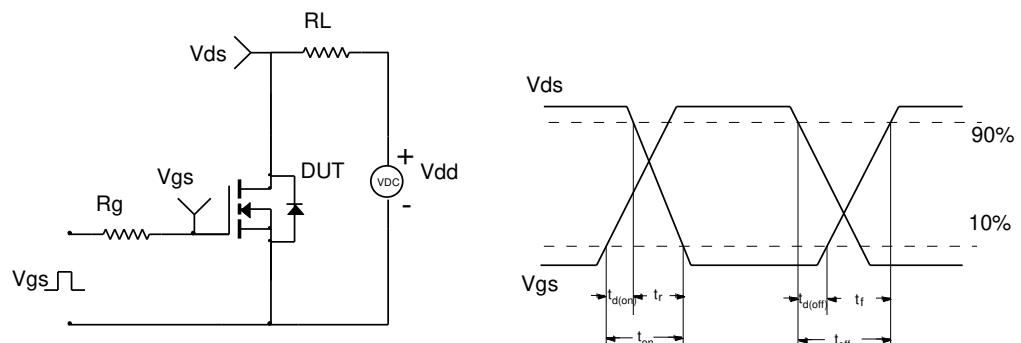


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

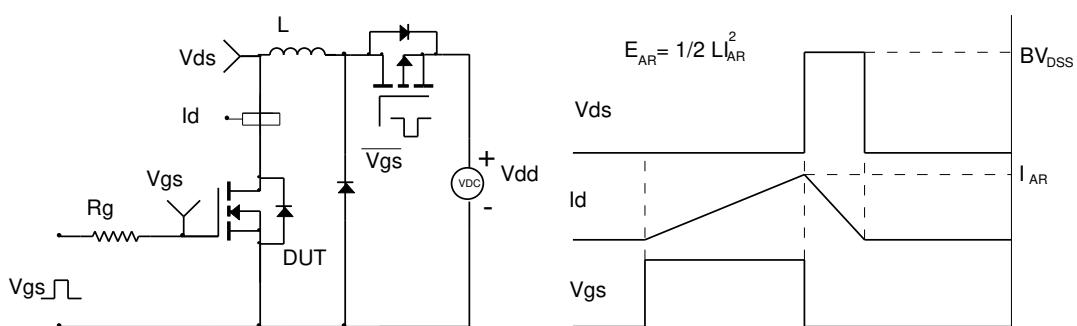


Figure D: Diode Recovery Test Circuit & Waveforms

